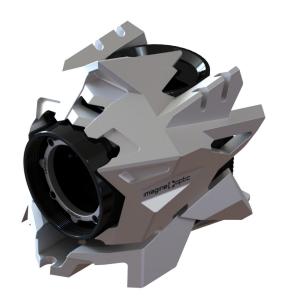


LIFT LP

Wavefront sensor **The cyclops**

Ultra-High spatial resolution Large analysis pupil High accuracy







With the LIFT LP, Imagine
Optic is extending its
portfolio with a large
pupil sensor, bringing
convenience to the
testing of large beams.

This generation of sensors features the SpotTracker™ technology. It provides absolute wavefront and tilt information, eliminating alignment requirements for faster and easier implementation.

APPLICATIONS

The LIFT LP is the perfect tool for direct characterization of relatively large optical beams without the need for relay optics to adapt the beam to the metrology tool. It is easier, faster to implement and more accurate: no more added optics means no more added aberrations and no need for specific setup calibration.

- + Laser beam testing, accurate laser collimation
- + Laser optical alignment and optimization to allow optimal M2-parameter values
- + Characterization of optics, lens, protective windows, mirror with transmitted wavefront error (TWE) and surface shape in reflection (SFE) using the same wavefront sensor and over a large spectral bandwidth
- + Production QC, specifications check of purchased optics prior to integration
- + Alignment of optical systems, based on live aberration information

FEATURES

LIFT LP packs:

- + Ultra-high spatial resolution of 512 x 512, allowing characterization over several hundreds of Zernike Polynomilas
- + 22 mm large analysis pupil for direct wavefront characterization without relay optics or beam conditioning
- + Accuracy of $\lambda/100$ RMS permitting small defects detection
- + Dynamic range superior to 1000 λ for direct wavefront acquisition of converging and diverging beams



SPECIFICATIONS*

OPERATING SPECS

Aperture dimension Number of microlenses Maximum acquisition frequency LP BROADBAND calibrated wavelength range LP VIS calibrated wavelength range Minimum power

10 Hz (10GigE) 400 - 1100 nm 400 - 800 nm 0.7 nW External trigger TTL signal Operating system Windows 11 & 10

OPTICAL SPECS

Repeatability Absolute wavefront measurement accuracy Spatial sampling Local radius of curvature dynamic range Beam aperture (f-number)

 $\sim 170 \, \mu m$ \pm 0.02 m to \pm ∞ > 5

MISC

Dimension (Height x Width x Length) Weight for USB version Working temperature Interface Power consumption

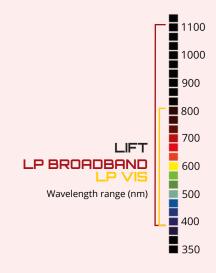
100.7 x 104.5 x 121 mm³ 800 g 15 - 30 °C 10GigE

22 x 22 mm² 512 x 512

< λ/200 RMS

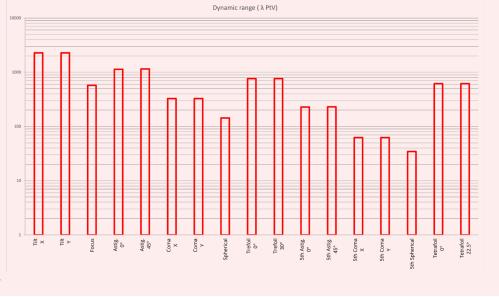
 λ 100 or 6 nm RMS

14 W (dep. on operating mode)



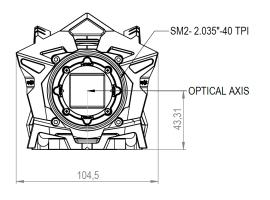


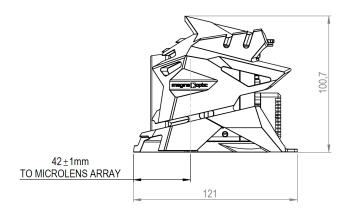
Dynamic range at λ = 635 nm



*Subject to changes without further notice Aquisition & processing frequencies depend on computer

DIMENSIONS (mm)





SOFTWARE

WAVEVIEW™ Metrology Software

WAVEVIEW™ is the most advanced wavefront measurement and analysis software.

It offers more than 150 features and tools optimized for a wide range of highly demanding applications.

Options:

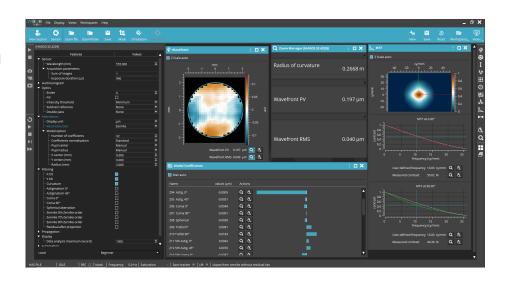
- + Extensions for PSF, MTF, M² and Strehl ratio
- + Optional SDK in C/C++, LabVIEW and Python

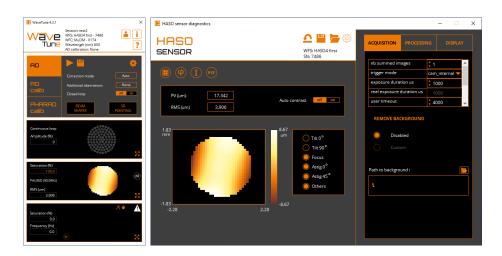
WAVETUNE™ Adaptive Optics Software

WAVETUNE™ is a unique software that seamlessly combines wavefront measurement and correction features with extensive instrument diagnostics. It is perfectly adapted to our HASO wavefront sensors, ILAO STAR, MIRAO and mu-DM deformable mirrors, as well as to a wide range of active components.

Options:

+ Optional SDK in C/C++, LabVIEW and Python





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